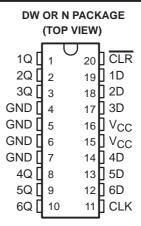
SCAS146 - MARCH 1990 - REVISED APRIL 1993

- Applications Include: Buffer/Storage Registers, Shift Registers, Pattern Generators
- Flow-Through Architecture Optimizes PCB Layout
- Center-Pin V_{CC} and GND Pin Configurations Minimize High-Speed Switching Noise
- EPIC[™] (Enhanced-Performance Implanted CMOS) 1-μm Process
- 500-mA Typical Latch-Up Immunity at 125°C
- Package Options Include Plastic Small-Outline Packages and Standard Plastic 300-mil DIPs



description

This device contains six D-type flip-flops and is positive-edge-triggered with a direct clear input. Information at the D inputs meeting the setup time requirements is transferred to the outputs on the positive-going edge of the clock pulse. Clock triggering occurs at a particular voltage level and is not directly related to the transition time of the positive-going pulse. When the clock input is at either the high or low level, the D input signal has no effect at the output.

The 74AC11174 is characterized for operation from - 40°C to 85°C.

FUNCTION TABLE

		INPUTS		OUTPUT
١	CLR	CLK	D	Q
	L	Х	Х	L
	Н	\uparrow	Н	Н
	Н	\uparrow	L	L
	Н	L	Χ	QO

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SCAS146 - MARCH 1990 - REVISED APRIL 1993

logic symbol† logic diagram (positive logic) 20 CLR R 11 CLK > C1 19 1D 1D 1Q CLK 18 2 2D 2Q 19 17 3 1D 3D 3Q 14 8 4D 4Q 13 9 R 5D 5Q 12 10 6Q 2D 1D [†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. R 1D R 1D R 1D R 12 10 R

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V _{CC}	0.5 V to 7 V
Input voltage range, V _I (see Note 1)	-0.5 V to V _{CC} + 0.5 V
Output voltage range, VO (see Note 1)	0.5 V to V _{CC} + 0.5 V
Input clamp current, I _{IK} (V _I < 0 or V _I > V _C	c) ±20 mA
Output clamp current, I _{OK} (V _O < 0 or V _O	> V _{CC}) ±50 mA
Continuous output current, I_O ($V_O = 0$ to	V _{CC}) ±50 mA
Continuous current through V _{CC} or GND	±150 mA
Storage temperature range	65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.



SCAS146 - MARCH 1990 - REVISED APRIL 1993

recommended operating conditions

		_	MIN	NOM	MAX	UNIT
Vcc	Supply voltage		3	5	5.5	V
		V _{CC} = 3 V	2.1			
V_{IH}	High-level input voltage	V _{CC} = 4.5 V	3.15			V
		V _{CC} = 5.5 V	3.85			
		V _{CC} = 3 V			0.9	
V_{IL}	Low-level input voltage	V _{CC} = 4.5 V			1.35	V
VIH VIL VI VO IOH LOL Δt/Δv		V _{CC} = 5.5 V			1.65	
VI	Input voltage		0		VCC	V
٧o	Output voltage		0		VCC	V
		V _{CC} = 3 V			-4	
loh	High-level output current	$V_{CC} = 4.5 \text{ V}$			-24	mA
		V _{CC} = 5.5 V			-24	
		V _{CC} = 3 V			12	
lOL	Low-level output current	V _{CC} = 4.5 V			24	mA
	High-level input voltage Low-level input voltage Input voltage Output voltage High-level output current	V _{CC} = 5.5 V			24	
Δt/Δν	Input transition rise or fall rate	2 3	0		10	ns/V
TA	Operating free-air temperature	2 12	-40		85	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	Voc	T/	A = 25°C	;	MINI	2.9 4.4 5.4 2.48 3.8 4.8	UNIT
PARAMETER	TEST CONDITIONS	vCC	MIN	TYP	MAX	IVIIIV		UNIT
		3 V	2.9			2.9		
	$I_{OH} = -50 \mu\text{A}$	4.5 V	4.4			4.4		
		5.5 V	5.4			5.4		
Voн	$I_{OH} = -4 \text{ mA}$	3 V	2.58			2.48		V
		4.5 V	3.94			3.8	2.9 4.4 5.4 4.8 3.8 4.8 85 0.1 0.1 0.1 0.44 0.44 1.65 ±1	
	$I_{OL} = -24 \text{ mA}$	No. No. No. No. No. No. No. No. No.						
	$I_{OH} = -75 \text{ mA}^{\dagger}$	5.5 V				3.85	0.1 0.1 0.1 0.44 0.44 1.65 ±1	
		3 V			0.1		0.1	
	I _{OL} = 50 μA	4.5 V			0.1		0.1 0.1 0.1 0.44 0.44 1.65 ±1	
		5.5 V			0.1		0.1	
VOL	I _{OL} = 12 mA	3 V			0.36		0.44	V
	lo 24 mA	4.5 V			0.36		0.44	
	I _{OL} = 24 mA	5.5 V			2.9 4.4 5.4 2.48 3.8 4.8 3.85 0.1 0.1 0.1 0.1 0.1 0.1 0.1 0.1 0.36 0.44 0.36 0.44 1.65 ±0.1 ±1 8 8 80			
	$I_{OL} = 75 \text{ mA}^{\dagger}$	5.5 V					1.65	
lį	$V_I = V_{CC}$ or GND	5.5 V			±0.1		±1	μΑ
ICC	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			8		80	μΑ
Ci	V _I = V _{CC} or GND	5 V		4				pF

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.



SCAS146 - MARCH 1990 - REVISED APRIL 1993

timing requirements over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

			T _A =	25°C	MIN	MAX	UNIT
			MIN	MAX	IVIIN	WAX	UNII
fclock	Clock frequency		0	80	0	80	MHz
	Pulse duration	CLR low	4.5		4.5		no
t _W	ruise duration	CLK high or low	6		6		ns
	Setup time before CLKT	Data	7		7		
^l su	Setup time before CLK↑	CLR inactive	1.5		1.5		ns
th	Hold time after CLK↑		0		0		ns

timing requirements over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

			T _A = 2	25°C	MIN	MAX	UNIT
			MIN	MAX	IVIIN	WAX	UNIT
fclock	Clock frequency		0	100	0	100	MHz
	Pulse duration	CLR low	4		4		no
t _W	ruise duration	CLK high or low	5		5		ns
	Setup time before CLK↑	Data	4.5		4.5		no
t _{su}	Setup time before CENT	CLR inactive	1.5		1.5		ns
t _h	Hold time after CLK↑	00,	0		0		ns

switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	ТО	T,	Δ = 25°C	;	MIN	MAX	UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	IVIIIV	WAX	UNII
f _{max}			80	105		80		MHz
t _{PHL}	CLR	Any Q	3.9	10	13.5	3.9	14.8	ns
t _{PLH}	CLK	Any Q	2.4	7.5	9.2	2.4	10.8	ne
^t PHL	CLK	Ally Q	3.4	9.6	12.7	3.4	14	ns

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	ТО	T,	Վ = 25°C	;	MIN MAX		UNIT
PARAWETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	IVIIIV	IVIAA	UNIT
f _{max}			100	125		100		MHz
^t PHL	CLR	Any Q	2.9	6.5	9.8	2.9	10.7	ns
^t PLH	CLK	Any Q	2.1	4.9	6.8	2.1	7.6	ne
^t PHL	CLK	Ally Q	2.7	6.2	9.2	2.7	10.1	ns

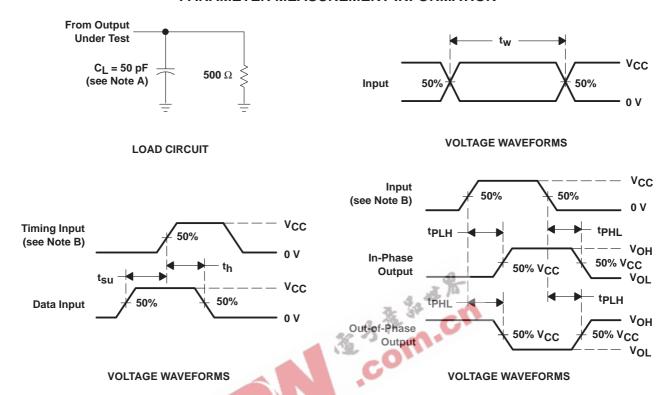
operating characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

PARAMETER	TEST CONDITIONS	TYP	UNIT
C _{pd} Power dissipation capacitance	$C_L = 50 \text{ pF}, f = 1 \text{ MHz}$	29	pF



SCAS146 - MARCH 1990 - REVISED APRIL 1993

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50 \Omega$, $t_f = 3 \text{ ns}$, $t_f = 3 \text{ ns}$.
- C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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